



RADIO TEST REPORT

Test Report No. : 12548845H-B

Applicant : **silex technology, Inc.**
Type of Equipment : **SDIO Wireless Module**
Model No. : **SX-SDMAN**
FCC ID : **N6C-SDMAN**
Test regulation : **FCC Part 15 Subpart E: 2018
(DFS test only)
*Client without radar detection**
Test Result : **Complied**

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
6. The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
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Date of test: November 30, 2018

Representative test engineer:

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Yuta Moriya
Engineer
Consumer Technology Division

Approved by:

T. Takayama
Tsubasa Takayama
Leader
Consumer Technology Division



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13-EM-F0429

CONTENTS	PAGE
SECTION 1: Customer information.....	4
SECTION 2: Equipment under test (E.U.T.).....	4
SECTION 3: Scope of Report.....	6
SECTION 4: Test specification, procedures & results.....	6
SECTION 5: Operation of E.U.T. during testing.....	11
SECTION 6: Channel Move Time, Channel Closing Transmission Time.....	17
SECTION 7: Non-Occupancy Period.....	19
APPENDIX 1: Test instruments	21
APPENDIX 2: Photographs of test setup	22

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SECTION 1: Customer information

Company Name : silex technology, Inc.
Address : 2-3-1 Hikaridai, Seika-cho, Kyoto 619-0237, Japan
Telephone Number : +81-774-98-3878
Facsimile Number : +81-774-98-3758
Contact Person : Toshiro Kometani

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : SDIO Wireless Module
Model No. : SX-SDMAN
Serial No. : Refer to Section 4, Clause 4.2
Rating : DC3.3V
Receipt Date of Sample : October 12, 2018
Country of Manufacture : Japan
Condition of EUT : Production prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab

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2.2 Product Description

Model: SX-SDMAN (referred to as the EUT in this report) is a SDIO Wireless Module.

Radio Specification

Radio Type : Transceiver
Method of Frequency Generation : Synthesizer

Specification of Wireless LAN (IEEE802.11b/g/a/n-20/n-40)

	IEEE802.11b	IEEE802.11g	IEEE802.11a	IEEE802.11n (20 M band)	IEEE802.11n (40 M band)
Frequency of operation	2412 MHz – 2462 MHz	2412 MHz -2462 MHz	5180 MHz - 5320 MHz 5500 MHz - 5580 MHz 5600 MHz - 5640 MHz *1) 5660 MHz - 5700 MHz 5745 MHz - 5825 MHz	2412 MHz - 2462 MHz 5180 MHz - 5320 MHz 5500 MHz - 5580 MHz 5600 MHz - 5640 MHz *1) 5660 MHz - 5700 MHz 5745 MHz - 5825 MHz	5190 MHz - 5310MHz 5510 MHz - 5550MHz 5590 MHz - 5630 MHz *1) 5670MHz 5755 MHz - 5795MHz
Type of modulation	DSSS (CCK, DQPSK, DBPSK)	OFDM-CCK (64QAM, 16QAM, QPSK, BPSK)	OFDM (64QAM, 16QAM, QPSK, BPSK)		
Channel spacing	5MHz		20MHz	<u>2.4GHz band</u> 5MHz <u>5GHz band</u> 20MHz	40MHz
Antenna type	Mini-Nanoblade antenna: Laird Technologies Stand Alone antenna: Molex				
Antenna Gain	Mini-Nanoblade antenna: 2.5dBi (2.4GHz), 4.8dBi (5GHz) Stand Alone antenna: 3.0dBi (2.4GHz), 4.6dBi (5GHz)				
Antenna Connector type	U.FL Alternative connector				

Specification of Bluetooth (Ver.4.0 + EDR)

Type of radio	Bluetooth
Frequency of Operation	2402-2480MHz
Type of Modulation	FHSS
Channel spacing	1MHz
Antenna type	Mini-Nanoblade antenna: Laird Technologies Stand Alone antenna: Molex
Antenna Gain	Mini-Nanoblade antenna: 2.5dBi (2.4GHz) Stand Alone antenna: 3.0dBi (2.4GHz)
Antenna Connector Type	U.FL Alternative connector

Specification of Low Energy (Ver.4.0 + EDR/LE Dual mode)

Type of radio	Low Energy
Frequency of Operation	2402-2480MHz
Type of Modulation	DSSS
Channel spacing	2MHz
Antenna type	Mini-Nanoblade antenna: Laird Technologies Stand Alone antenna: Molex
Antenna Gain	Mini-Nanoblade antenna: 2.5dBi (2.4GHz) Stand Alone antenna: 3.0dBi (2.4GHz)
Antenna Connector Type	U.FL Alternative connector

*This test report applies for Wireless LAN (IEEE802.11a/n-20/n-40).

*1) 5600 MHz -5640 MHz and 5590 MHz – 5630 MHz are applied for this test report.

Wireless LAN and Bluetooth do not transmit simultaneously.

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SECTION 3: Scope of Report

This report only covers DFS requirement, as specified by the following referenced procedures.

SECTION 4: Test specification, procedures & results

4.1 Test Specification

Test Specification	:	FCC Part 15 Subpart E
Title	:	FCC 47CFR Part15 Radio Frequency Device Subpart E Unlicensed National Information Infrastructure Devices Section 15.407 General technical requirements
Test Specification	:	KDB905462 D02 UNII DFS Compliance Procedures New Rules v02
Title	:	COMPLIANCE MEASUREMENT PROCEDURES FOR UNLICENSED- NATIONAL INFORMATION INFRASTRUCTURE DEVICES OPERATING IN THE 5250-5350MHz AND 5470-5725MHz BANDS INCORPORATING DYNAMIC FREQUENCY SELECTION
Test Specification	:	KDB905462 D03 Client Without DFS New Rules v01r02
Title	:	U-NII CLIENT DEVICES WITHOUT RADAR DETECTION CAPABILITY

FCC Part 15.31 (e)

The RF Module has own regulator. The RF Module is constantly provided voltage through own regulator regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

The EUT has a unique antenna connector (U.FL). Therefore the equipment complies with the requirement of 15.203/212.

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4.2 Procedures and results

Table 1: Applicability of DFS Requirements

Requirement	Operating Mode	Test Procedures & Limits	Deviation	Results
	Client without Radar Detection			
U-NII Detection Bandwidth	Not required	KDB905462 D02 UNII DFS Compliance Procedures New Rules v02	N/A	N/A
Initial Channel Availability Check Time	Not required	FCC15.407 (h)	N/A	N/A
		KDB905462 D02 UNII DFS Compliance Procedures New Rules v02		
		RSS-247 6.3		
Radar Burst at the Beginning of the Channel Availability Check Time	Not required	FCC15.407 (h)	N/A	N/A
		KDB905462 D02 UNII DFS Compliance Procedures New Rules v02		
		RSS-247 6.3		
Radar Burst at the End of the Channel Availability Check Time	Not required	FCC15.407 (h)	N/A	N/A
		KDB905462 D02 UNII DFS Compliance Procedures New Rules v02		
		RSS-247 6.3		
In-Service Monitoring for Channel Move Time, Channel Closing Transmission Time	Yes	FCC15.407 (h)	N/A	Complied
		KDB905462 D02 UNII DFS Compliance Procedures New Rules v02		
		RSS-247 6.3		
In-Service Monitoring for Non-Occupancy period	Yes *	FCC15.407 (h)	N/A	Complied
		KDB905462 D02 UNII DFS Compliance Procedures New Rules v02		
		RSS-247 6.3		
Statistical Performance Check	Not required	FCC15.407 (h)	N/A	N/A
		KDB905462 D02 UNII DFS Compliance Procedures New Rules v02		

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0422.

*Although this test was not required in FCC, KDB 905462 D02, it was performed as additional test.

Table 2 DFS Detection Thresholds for Master Devices and Client Devices With Radar Detection

Maximum Transmit Power	Value (See Notes 1,2, and 3)
≥ 200 milliwatt	-64 dBm
< 200 milliwatt and power spectral density < 10dBm/MHz	-62 dBm
< 200 milliwatt that do not meet the power spectral density requirement	-64 dBm
<p>Note 1: This is the level at the input of the receiver assuming a 0 dBi receive antenna.</p> <p>Note 2: Throughout these test procedures an additional 1 dB has been added to the amplitude of the test transmission waveforms to account for variations in measurement equipment. This will ensure that the test signal is at or above the detection threshold level to trigger a DFS response.</p> <p>Note 3: EIRP is based on the highest antenna gain. For MIMO devices refer to KDB Publication 662911 D01.</p>	

Table 3 DFS Response Requirement Values

Parameter	Value
Non-occupancy period	Minimum 30 minutes
Channel Availability Check Time	60 seconds
Channel Move Time	10 seconds See Note 1
Channel Closing Transmission Time	200 milliseconds + an aggregate of 60 milliseconds over remaining 10 second period. See Notes 1 and 2
U-NII Detection Bandwidth	Minimum 100 % of the U-NII 99 % transmission power bandwidth See Note 3
<p>Note 1: Channel Move Time and the Channel Closing Transmission Time should be performed with Radar Type 0. The measurement timing begins at the end of the Radar Type 0 burst.</p> <p>Note 2: The Channel Closing Transmission Time is comprised of 200 milliseconds starting at the beginning of the Channel Move Time plus any additional intermittent control signals required to facilitate a Channel move (an aggregate of 60 milliseconds) during the remainder of the 10 second period. The aggregate duration of control signal will not count quiet periods in between transmissions.</p> <p>Note 3: During the U-NII Detection Bandwidth detection test, radar type 0 should be used. For each frequency step the minimum percentage of detection is 90 percent. Measurements are performed with no data traffic.</p>	

Table 4 Short Pulse Radar Test Waveform

Radar Type	Pulse Width (μsec)	PRI (μsec)	Number of Pulses	Minimum Percentage of Successful Detection	Minimum Number of Trials
0	1	1428	18	See Note 1	See Note 1
1	1	Test A: 15 unique PRI values randomly selected from the list of 23 PRI values in Table 5a	Roundup{(1/360)* (19*10 ⁶ /PRI μsec)}	60 %	30
		Test B: 15 unique PRI values randomly selected within the range of 518-3066 μsec, with a minimum increment of 1 μsec, excluding PRI values selected in Test A			
2	1-5	150-230	23-29	60 %	30
3	6-10	200-500	16-18	60 %	30
4	11-20	200-500	12-16	60 %	30
Aggregate (Rader Types 1-4)				80 %	120
Note 1: Short Pulse Radar Type 0 should be used for the detection bandwidth test, channel move time, and channel closing time tests.					

Table 5 Long Pulse Radar Test Waveform

Radar Type	Pulse Width (μsec)	Chip Width (MHz)	PRI (μsec)	Number of Pulses per Burst	Number of Burst	Minimum Percentage of Successful Detection	Minimum Number of Trials
5	50-100	5 - 20	1000-2000	1-3	8-20	80 %	30

Table 6 Frequency Hopping Radar Test Waveform

Radar Type	Pulse Width (μsec)	PRI (μsec)	Pulse per Hop (kHz)	Hopping Rate (kHz)	Hopping Sequence Length (msec)	Minimum Percentage of Successful Detection	Minimum Number of Trials
6	1	333	9	0.333	300	70 %	30

4.3 Addition to standard

No addition, exclusion nor deviation has been made from the standard.

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4.4 Test Location

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NVLAP Lab. code: 200572-0 / FCC Test Firm Registration Number: 199967

Test site	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.6 shielded room	-	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	-	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	-	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	-	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	-	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	-	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 m x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

4.5 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2. Time Measurement uncertainty for this test was: (±) 0.012%

4.6 Test instruments of DFS and Test set up

Refer to APPENDIX.

SECTION 5: Operation of E.U.T. during testing

5.1 Operating Modes

The EUT, which is a Client Device without Radar detection capability, operates over the U-NII-2C.

*Refer to 12548845H-A FCC Part 15E (FCC 15.407) report for other parts than DFS.

The channel-loading of approximately 17% or greater was used for testing, and its test data was transferred from the Master Device to the Client Device for all test configurations.

The EUT utilizes the 802.11a/n architecture, with a 20MHz and 40MHz channel bandwidth.

The FCC ID for the Master Device used with EUT for DFS testing is N6C-SXPCEAC.

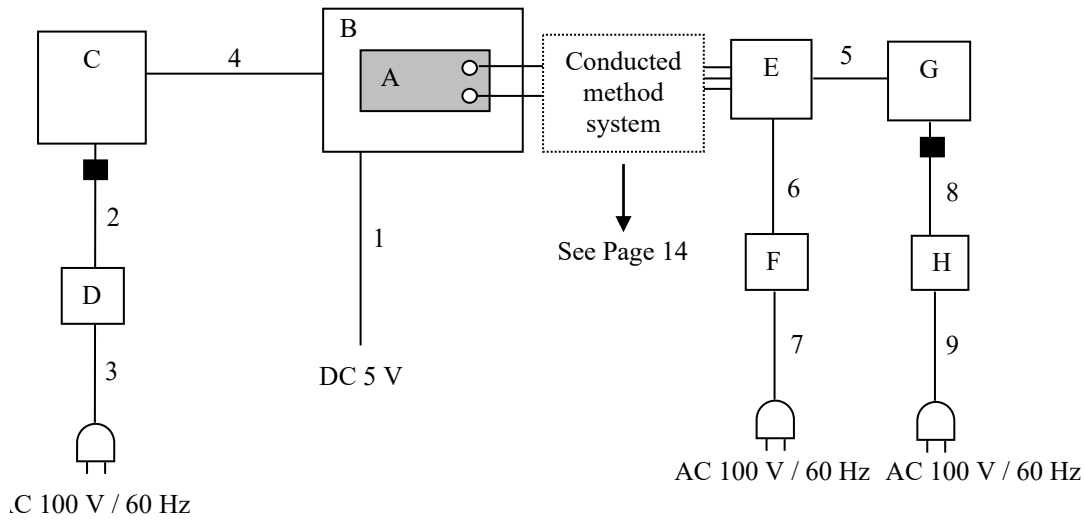
The rated output power of the Master unit is >200mW(23dBm). Therefore the required interference threshold level is -64 dBm. After correction for antenna gain and procedural adjustments, the required conducted threshold at the antenna port is $-64 + 1 + 0 = -63.0$ dBm (threshold level + additional 1dB + antenna gain).

It is impossible for users to change DFS control, because the DFS function is written on the firmware and users cannot access it.

The EUT was set by the software as follows:

Software name & version: HW: PW08090, SW: iperf ver.2.05

5.2 Configuration and peripherals



■ : Standard Ferrite Core

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	SDIO Wireless Module	SX-SDMAN	008092-50990A	silex technology, Inc.	EUT
B	Jig Board	-	-	silex technology, Inc.	-
C	Laptop PC	CF-N8HWCDPS	0BKSA08723	Panasonic	-
D	AC Adaptor	CF-AA637213	6372BM409X18054B	Panasonic	-
E	Access Point	AP-500AC	001629771	silex technology, Inc.	-
F	AC Adaptor	ATS 036T-A120	001	ADAPTER TECH.	-
G	Laptop PC	CF-N8HWCDPS	0BKSA07449	Panasonic	-
H	AC Adaptor	CF-AA637213	6372BM409X10729813	Panasonic	-

List of cables used

No.	Name	Length (m)	Shield	
			Cable	Connector
1	DC Cable	0.5	Unshielded	Unshielded
2	DC Cable	1.0	Unshielded	Unshielded
3	AC Cable	0.9	Unshielded	Unshielded
4	Signal Cable	2.8	Shielded	Shielded
5	LAN Cable	1.5	Unshielded	Unshielded
6	DC Cable	1.5	Unshielded	Unshielded
7	AC Cable	1.0	Unshielded	Unshielded
8	DC Cable	1.0	Unshielded	Unshielded
9	AC Cable	0.9	Unshielded	Unshielded

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5.3 Test and Measurement System

SYSTEM OVERVIEW

The measurement system is based on a conducted test method.

The software selects waveform parameters from within the bounds of the signal type on a random basis using uniform distribution. The short pulse types 1, 2, 3, and 4, the long pulse type 5, and the frequency hopping type 6 parameters are randomized at run-time.

The signal monitoring equipment consists of a spectrum analyzer with the capacity to display 8001 bins on the horizontal axis. A time-domain resolution of 2 msec/bin is achievable with a 16 second sweep time, meeting the 10 seconds short pulse reporting criteria. The aggregate ON time is calculated by multiplying the number of bins above a threshold during a particular observation period by the dwell time per bin, with the analyzer set to peak detection.

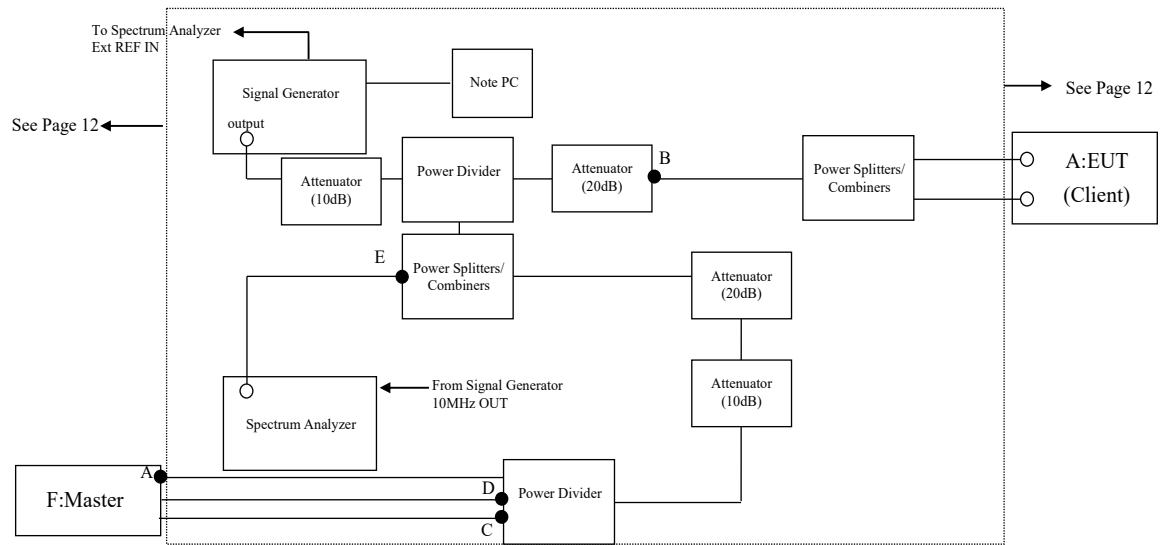
FREQUENCY HOPPING RADAR WAVEFORM GENERATING SUBSYSTEM

The first 100 frequencies are selected out of the hopping sequence of the randomized 475 hop frequencies.

Only a *Burst* that has the frequency falling within the receiver bandwidth of the tested U-NII device is selected among those frequencies. (Frequency-domain simulation). The radar waveform generated at the start time of the selected *Burst* (Time-domain simulation) is download to the Signal Generator.

If all of the randomly selected 100 frequencies do not fall within the receiver bandwidth of the U-NII device, the radar waveform is not used for the test.

CONDUCTED METHODS SYSTEM BLOCK DIAGRAM



MEASUREMENT SYSTEM FREQUENCY REFERENCE

Lock the signal generator and the spectrum analyzer to the same reference sources as follows: Connect the 10 MHz OUT on the signal generator to the EXT REF IN on the spectrum analyzer and set the spectrum analyzer Ext to On.

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SYSTEM CALIBRATION

Step 1: Set the system as shown in Figure 3 of KDB905462 D02 7.2.2.

Step 2: Adjust each attenuator to fulfill the following three conditions:

- WLAN can be communicated, and
- Rader detection threshold level is bigger than Client Device traffic level on the spectrum analyzer, and
- Master Device traffic level is not displayed on the spectrum analyzer.

Step 3: Terminate 50 ohm at B , C , D and E points, and connect the spectrum analyzer to the point A. (See the figure on page 14)

At the point A, adjust the signal generator and spectrum analyzer to the center frequency of the channel to be measured.

Download the applicable radar waveforms to the signal generator. Select the radar waveform, trigger a burst manually and measure the amplitude on the spectrum analyzer. Readjust the amplitude of the signal generator as required so that the peak level of the waveform is at a displayed level equal to the required or desired interference detection threshold.

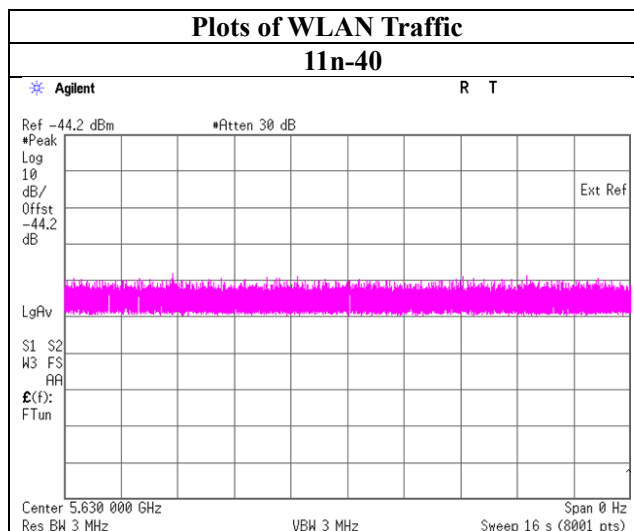
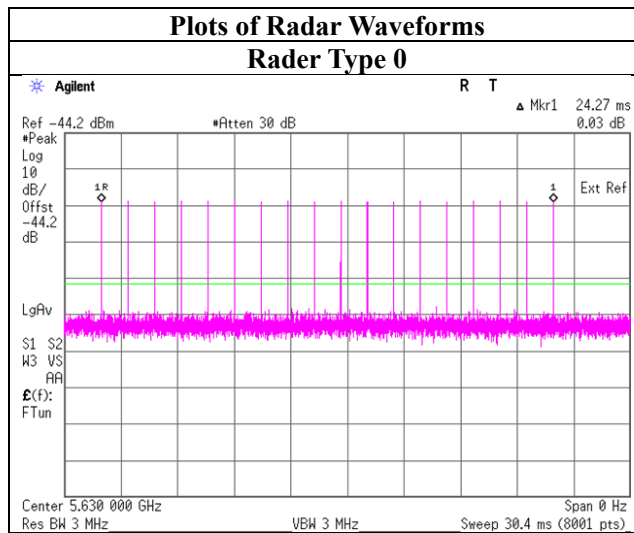
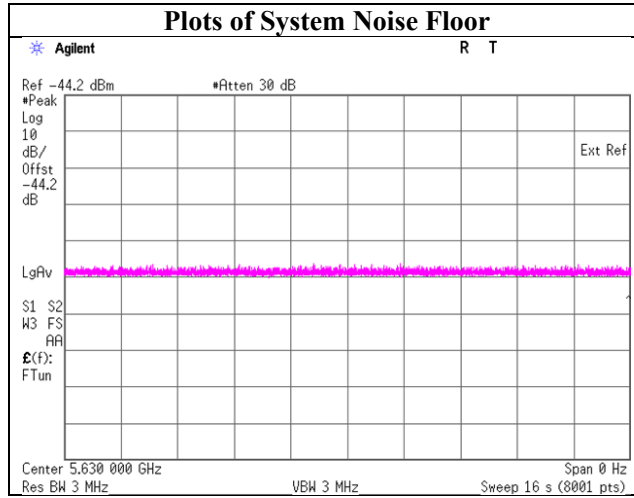
Separate signal generator amplitude settings are determined as required for each radar type.

Step 4: Without changing any of the instrument settings, restore the system setting to Step 2 and adjust the Reference Level Offset of the spectrum analyzer to the level at Step 3.

By taking the above steps 1 to 4, the spectrum analyzer displays the level of the signal generator as received at the antenna ports of the Master Device.

See Clause 5.4 for Plots of Noise, Rader Waveforms, and WLAN signals.

5.4 Plots of Noise, Rader Waveforms, and WLAN signals



SECTION 6: Channel Move Time, Channel Closing Transmission Time

6.1 Operating environment

Test place Ise EMC Lab.No.6 Measurement Room
Date November 30, 2018
Temperature/ Humidity 24 deg. C / 26 % RH
Engineer Yuta Moriya
Mode 11n-40

6.2 Test Procedure

Transmit the data from the Master Device to the Client Device on the test Channel for the entire period of the test. The Radar Waveform generator sends a Burst of pulses for one of the Short Pulse Radar Types 0 at levels defined , on the Operating Channel. An additional 1 dB is added to the radar test signal to ensure it is at or above the DFS Detection Threshold, accounting for equipment variations/errors. Observe the transmissions of the EUT at the end of the radar Burst on the Operating Channel for duration greater than 10 seconds.

6.3 Test data

11n-40

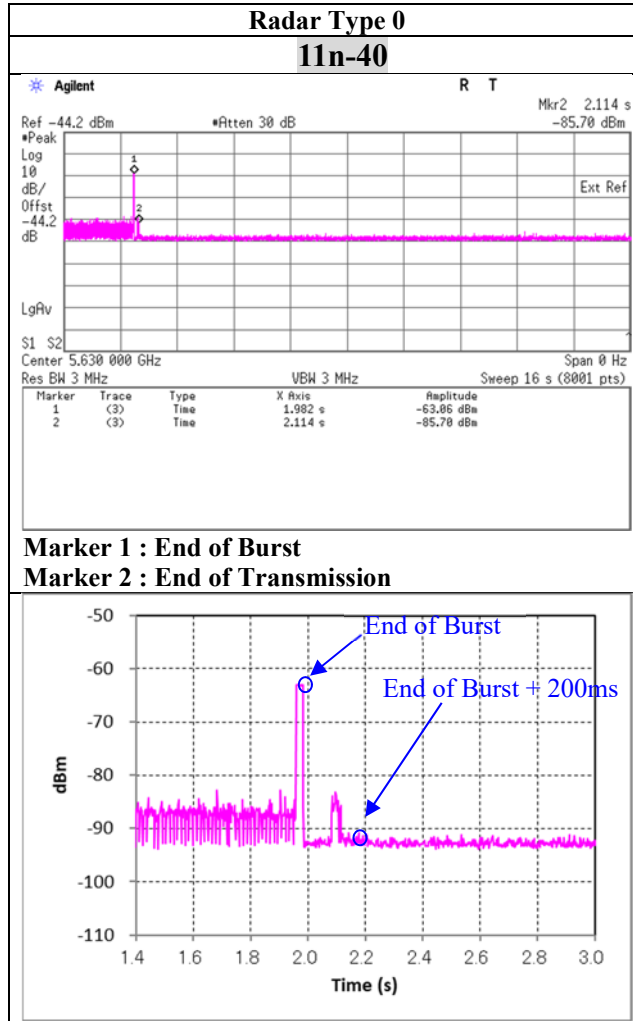
Test Item	Unit	Measurement Time	Limit	Results
Channel Move Time *1)	[sec]	0.132	10.000	Pass
Channel Closing Transmission Time *2)	[msec]	24	60	Pass

*1) Channel Move Time is calculated as follows:

$$(\text{Channel Move Time}) = (\text{End of Transmission}) - (\text{End of Burst}) = 2.114 - 1.982$$

*2) Channel Closing Transmission Time is calculated from (End of Burst + 200msec) to (End of Burst + 10sec)

$$(\text{Channel Closing Transmission Time}) = (\text{Number of analyzer bins showing transmission}) \times (\text{dwell time per bin}) \\ = 12 \times 2 [\text{msec}]$$



6.4 Test result

Test result: Pass

SECTION 7: Non-Occupancy Period

7.1 Operating environment

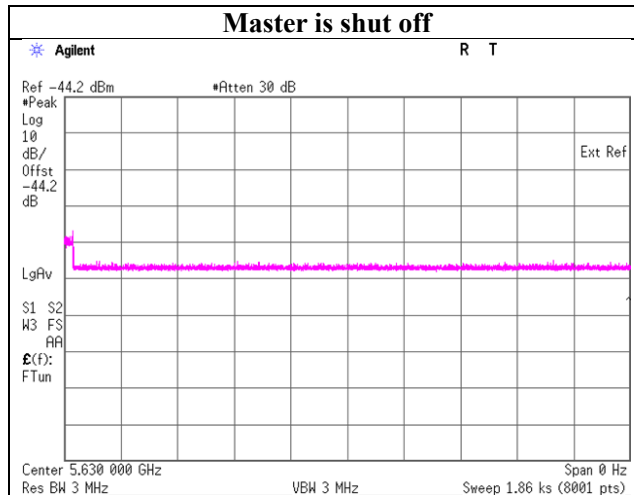
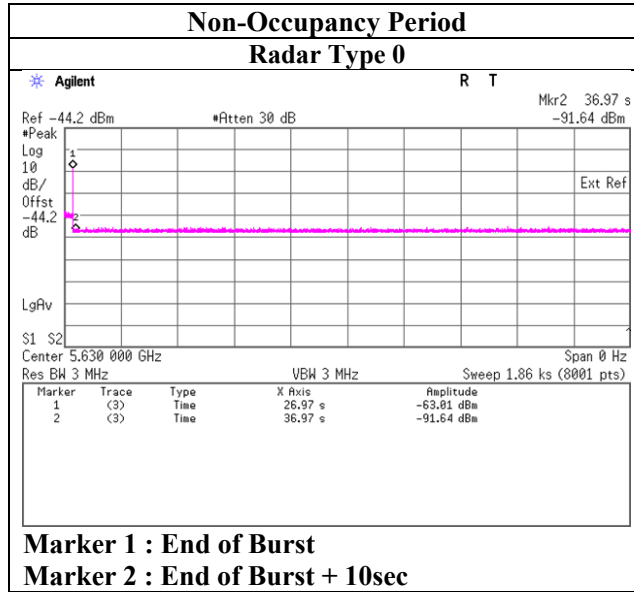
Test place	Ise EMC Lab.No.6 Measurement Room
Date	November 30, 2018
Temperature/ Humidity	24 deg. C / 26 % RH
Engineer	Yuta Moriya
Mode	11n-40

7.2 Test Procedure

The following two tests are performed:

- 1). Transmit the data from the Master Device to the Client Device on the test Channel for the entire period of the test. The Radar Waveform generator sends a Burst of pulses for one of the Radar Types 0 at levels defined on the Operating Channel. An additional 1 dB is added to the radar test signal to ensure it is at or above the DFS Detection Threshold, accounting for equipment variations/errors. Observe the transmissions of the EUT after the Channel Move Time on the Operating Channel for duration greater than 30 minutes.
- 2). Transmit the data from the Master Device to the Client Device on the test Channel for the entire period of the test. Observe the transmissions of the EUT on the Operating Channel for duration greater than 30 minutes after the Master Device is shut off.

7.3 Test data



7.4 Test result

Test result: Pass

APPENDIX 1: Test instruments

Test Instruments

Test Item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Calibration Due Date	Cal Int
DFS	141391	Microwave Cable	RS Pro	R-132G7210200CD	-	04/11/2018	04/30/2019	12
DFS	141375	Microwave Cable 1G-40GHz	Suhner	SUCOFLEX102	30817/2	05/11/2018	05/31/2019	12
DFS	141547	DIGITAL HiTESTER	HIOKI	3805	60500120	02/07/2018	02/28/2019	12
DFS	142820	Terminator	-	50ΩSMA	-	-	-	-
DFS	141561	Thermo-Hygrometer	CUSTOM	CTH-201	1401	01/24/2018	01/31/2019	12
DFS	142738	Power Splitters/Combiners	Mini-Circuits	ZFRSC-4-842-S+	2	-	-	-
DFS	142736	Power Splitters/Combiners	PASTERNAK ENTERPRISES	ZFRSC-123-S+	ZFRSC-123-00232	-	-	-
DFS	142735	Power Splitters/Combiners	PASTERNAK ENTERPRISES	ZFRSC-123-S+	ZFRSC-123-00231	-	-	-
DFS	141903	Spectrum Analyzer	AGILENT	E4440A	MY46186390	09/20/2018	09/30/2019	12
DFS	141821	Power Splitters/Combiners	Mini-Circuit	ZFSC-2-10G	326	09/18/2018	09/30/2019	12
DFS	142304	Attenuator(20dB)	Suhner	6820.19.A	-	-	-	-
DFS	142303	Attenuator(20dB)	Suhner	6820.19.A	-	-	-	-
DFS	142376	Microwave Cable	Junkosha	MWX-221-02000DMSDMS	1507S108	-	-	-
DFS	141897	Signal Generator	KEYSIGHT	N5182B	MY56200024	11/16/2018	11/30/2019	12
DFS	141312	Attenuator	Weinschel Associates	WA56-10	56100304	05/29/2018	05/31/2019	12
DFS	141223	Attenuator	Weinschel Associates	WA56-10	56100306	05/29/2018	05/31/2019	12
DFS	141322	Microwave Cable	RS Pro	R-132G7210200CD	-	04/11/2018	04/30/2019	12
DFS	141287	Microwave Cable	RS Pro	R-132G7210200CD	-	02/13/2018	02/28/2019	12
DFS	141288	Microwave Cable	RS Pro	R-132G7210200CD	-	06/12/2018	06/30/2019	12
DFS	141289	Microwave Cable	RS Pro	R-132G7210200CD	-	04/26/2018	04/30/2019	12
DFS	141224	Microwave Cable	Junkosha	MWX221	1409S496	03/30/2018	03/31/2019	12
DFS	141225	Microwave Cable	Junkosha	MWX221	1409S497	03/14/2018	03/31/2019	12
DFS *1)	170949	Signal Studio for DFS Radar Profiles	KEYSIGHT	N7607B	-	-	-	-

*Hyphens for Last Calibration Date, Calibration Due Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

*1) Signal generator is only used to generate radar test signal, and the wave form is confirmed with spectrum analyzer every time before the test.

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

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Test item:

DFS: Dynamic Frequency Selection

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